2010 International Conference on Risk and Reliability Management (2010 RRM)

2010 International Conference on Risk and Reliability Management (2010 RRM) is the premier international forum for disseminating recent advances in the field of risk and reliability management. It will provide the central meeting place for risk management and reliability practitioners, researchers, and vendors working in all disciplines in industrial, governmental, and academic sectors. It is sponsored by School of Management and Economics, Beijing Institute of Technology and School of Engineering & Applied Science, George Washington University.

SPONSOR:

School of Management and Economics, Beijing Institute of Technology School of Engineering & Applied Science, George Washington University

CO-ORGANIZER:

Systems Engineering Society of Beijing College of Business, The University of Texas The Hong Kong Polytechnic University The Reliability Branch of OR Society of China

TOPICS: 2010 RRM features a comprehensive program in risk and reliability management in industry. Contributions to the technical program are solicited in the following areas, however, papers in all areas of risk and reliability management will be considered:

Part a: risk Management Part b: reliability general methodology/modeling □energy risk management market risk management □analysis of reliability data □credit risk management □fault diagnosis operational risk management □maintenance □integrated risk management product reliability/safety □real options □network reliability and □enterprise risk management optimization supply chain and logistics risk management maintenance modeling project risk management maintenance optimization technical risk management □survival analysis schedule risk management □estimation and statistical tests cost risk management accelerated life testing □risk identification warranty analysis qualitative risk analysis □human reliability simulation methods in risk analysis □fault-tolerant computing

crisis response and emergency management	software reliability and testing
nazard identification of major accidents	□Bayesian reliability
risk analysis of natural disasters	dependability modeling
risk analysis of catastrophic accidents	□others
risk analysis of public health	
□others	

PUBLICATION: All contributed paper submissions will be **peer reviewed**. Accepted papers will be published in the conference proceedings, which will be indexed by ISTP. A selection of excellent papers will be published in special issues of **EI or SCI journals**. A paper must accompany all presentations and tutorials.

PAPER SUBMISSION: Electronically submit contributed papers not previously published or presented. Each submission must be a 4 to 8 page paper, including an abstract of not more than 150 words. Submission implies that an author will attend 2010 RRM to present the paper. Use of one of the following formats is required: Microsoft Word or LaTeX. Submissions must be made through the conference mail box at "rrm2010@126.com". Please refer to our paper template.

IMPORTANT DATES:

July 15, 2010	Paper should be submitted before this date.
August 15, 2010	Contributors will be notified whether or not their paper has been accepted.
September 15, 2010	Authors electronically provide a final manuscript meeting all requirements to the Proceedings Editor.
October 23-24, 2010	2010 RRM will be held in Beijing Institute of Technology in People's Republic of China at the International Education and Exchange Center

For additional information, please contact the conference mail box at "rrm2010@126.com".

EXCURSION TO HISTORIC SITES

The excursion to the Great Wall will take place on October 25.

CONTACT:

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